

13/01/22

Secondary stopping kaon analysis

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Update

- The event selection has been optimized and tested with all 6 GeV data (reco2 production).
 - It provides enough statistics and purity for a significant dEdx measurement.
- Firsts dEdx vs Residual Range plots are ready.
 - They could be used as a control sample for a systematic error.
- Starting to think about a XS measurement.

Previous talks: <u>September CM</u>, <u>22/07/2021</u>, <u>16/06/2021</u>, <u>26/05/2021</u>



Event selection optimization

- The selection has been optimized by **maximizing the product** Efficiency*Purity.
- The optimization process has simplified the selection.
- The optimization has allowed to avoid cutting on the kaon CNNs, which could have biased the dEdx measurement.

 All plots that are being shown use all 6 GeV data (reco2 production) and all 6 GeV MC (PDSPProd4a_MC_6GeV_gen_datadriven_reco1_sce_datadriven_v1 _0i)



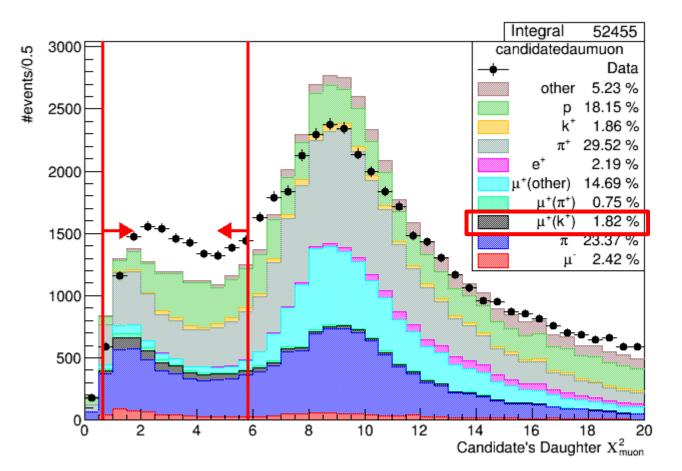
Preselection in a nutshell

- Secondary kaons are produced in hadronic reactions generated by the beam particle \rightarrow beam PDG = 211, 321 or 2212.
- Kaon main decay channel (63%) $K^+ \to \mu^+ \nu_\mu$ provides a way of identifying decaying kaons: they must have a single reconstructed daughter (track-like).
- Muon (daughter) kinematics can be used to identify the decaying kaon.
- Preselection summary: we are looking for non-primary particles with a single daughter (track-like) in beam hadron events.

2-body decay!

Daughter Chi² cut

- Decaying kaon's daughter should be a muon and this is reflected on the Chi² (muon hypothesis distribution).
- More restrictive cut than before.
- The discrepancies data-MC are due to broken tracks on APAs (see next slide)





Daughter Chi² cut

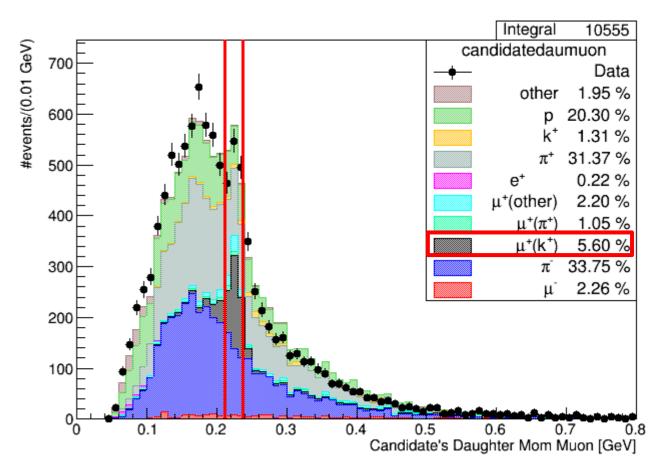
Excluding tracks starting/ending around APAs border we can see a better agreement data-MC Integral #events/0.5 Integral Candidate's Daughter Start Z [cm] Candidate's Daughter X²_{muon}

Exclude this tracks from the selection for the moment. It should be possible to fix this difference with a weight systematic.



Daughter mom by range

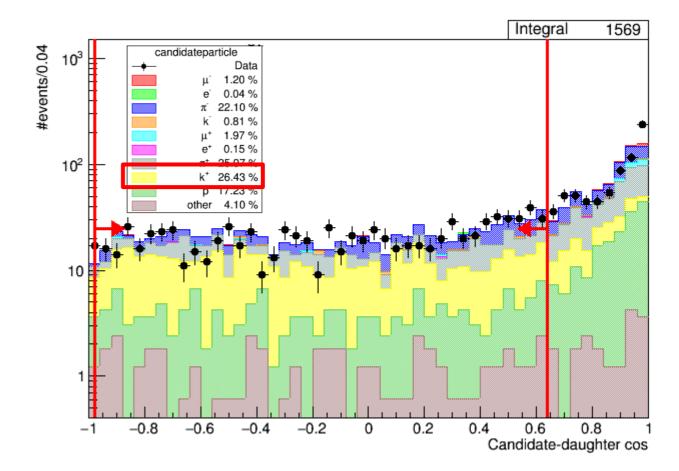
- Kaon decay is a twobody decay so muon momentum is very well defined.
- Very good agreement data-MC.





Cos(candidate-daughter)

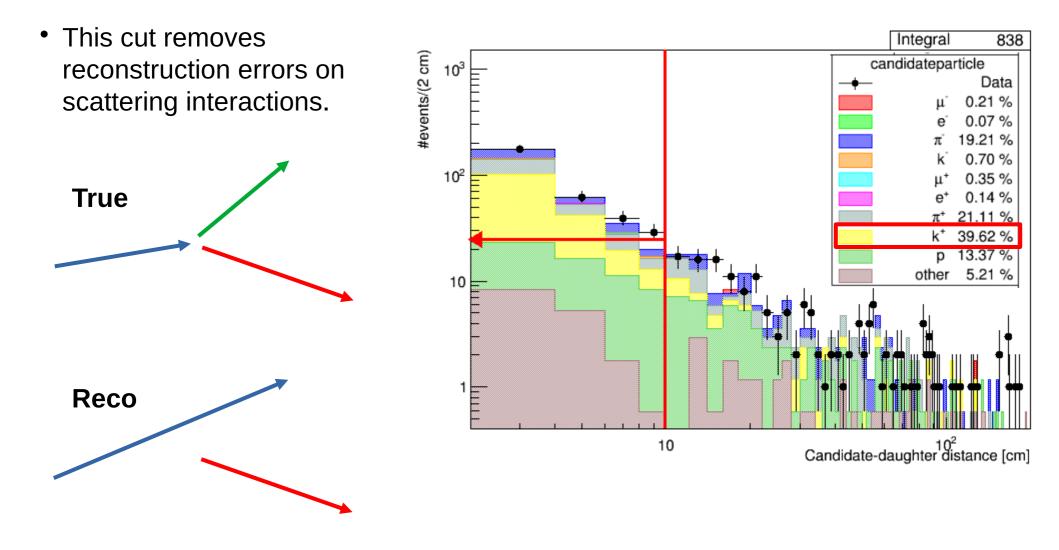
 Kaon decay is at rest so kaon-muon angle distribution should be isotropic and we can focus on the backward part.





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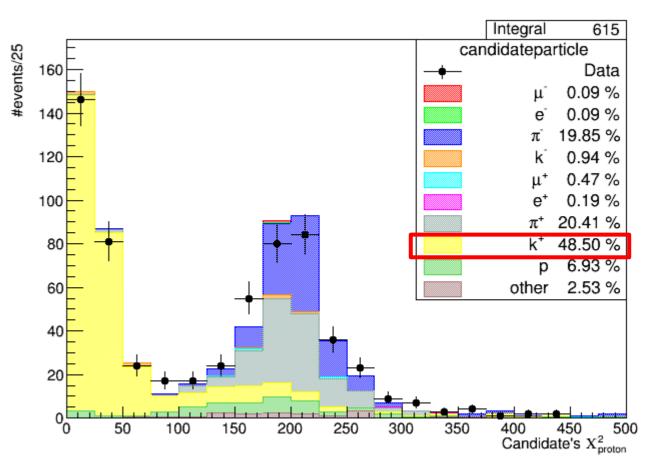
Distance candidate-daughter



EUTRINO EXPERIMENT

Event Selection result

- The event selection has almost 50% purity, and both distributions (signal and background) can be clearly differentiated in data and MC.
- Good agreement data-MC.
- We have about 300 kaons, enough for a significant measurement. We still have to add 7GeV runs, so a final population of 500-600 kaons is expected.

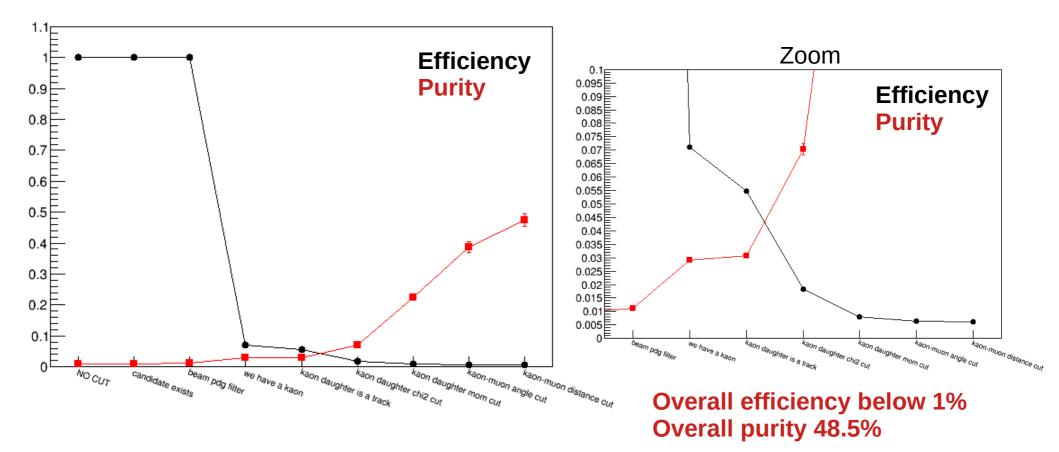


The current selection does not cut on the CNN of the kaon candidate. In that way
we avoid a potential dEdx bias.



Efficiency and Purity

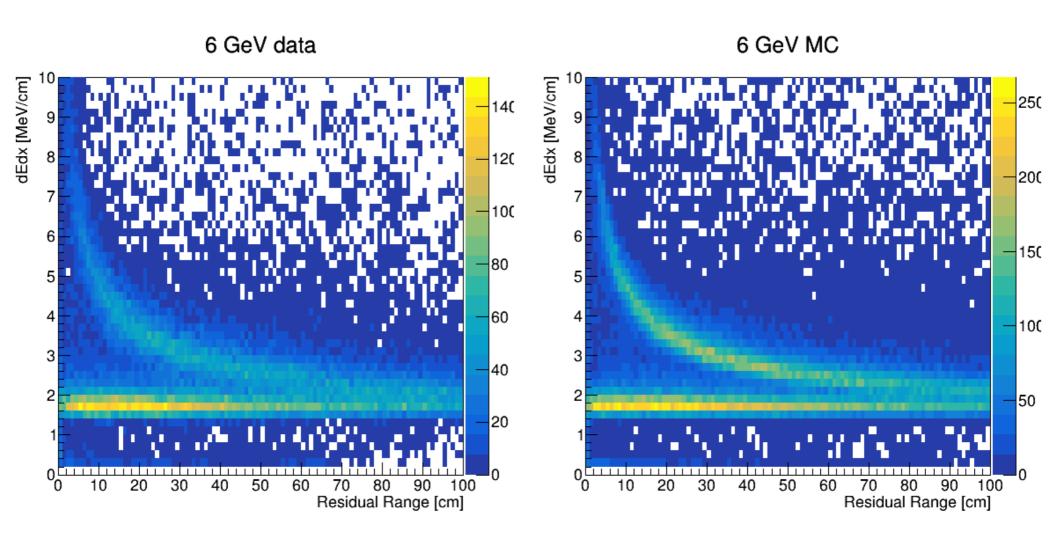
Most of the decaying kaons are lost because they are not reconstructed or because they are not properly reconstructed (no daughter associated)



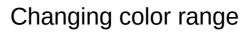


Cut	True Candidates (Eff %)	Purity (%)
Beam PDG	87747	1.1%
Candidate Exists	6921 (7.9%)	2.9%
Daughter track	5297 (6.0%)	3.1%
Daughter Chi ²	1705 (1.9%)	7.0%
Daughter Mom	702 (0.80%)	22.5%
Cos(daughter- mother)	567 (0.65%)	38.8%
Dis(daughter- mother)	540 (0.062%)	47.5%









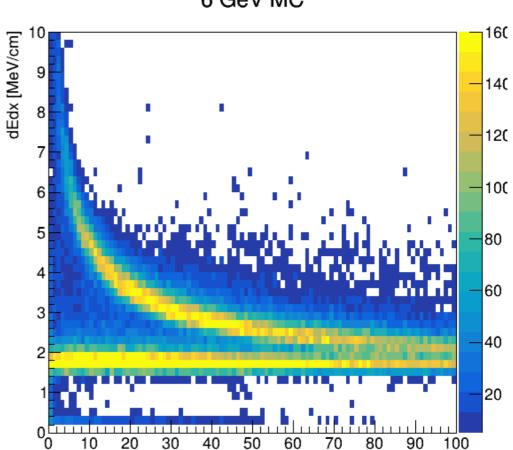
Residual Range [cm]

6 GeV data

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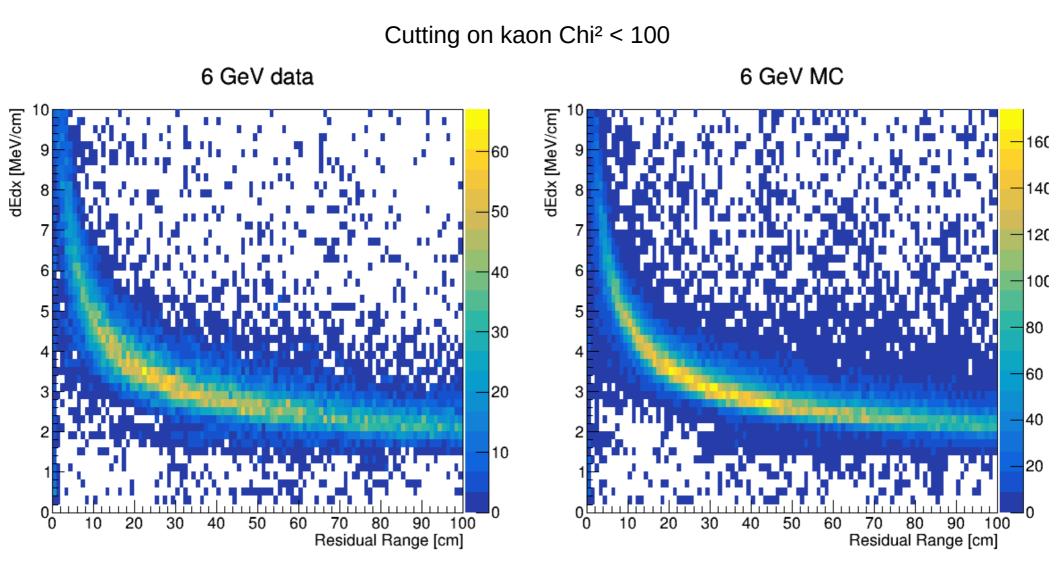
dEdx [MeV/cm]



6 GeV MC

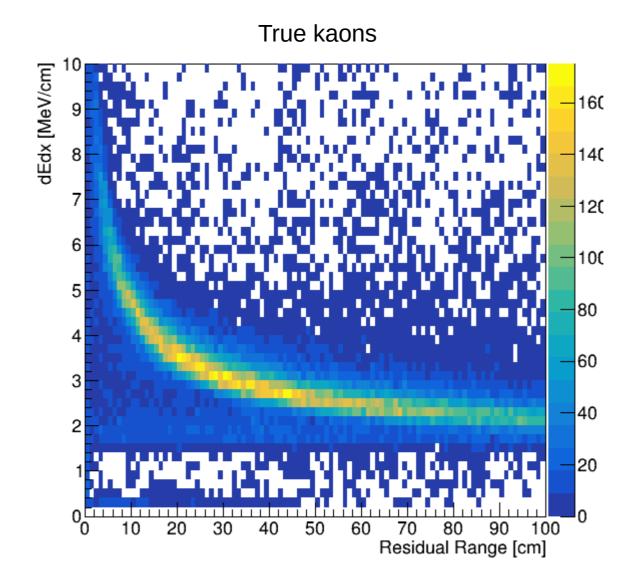


Residual Range [cm]

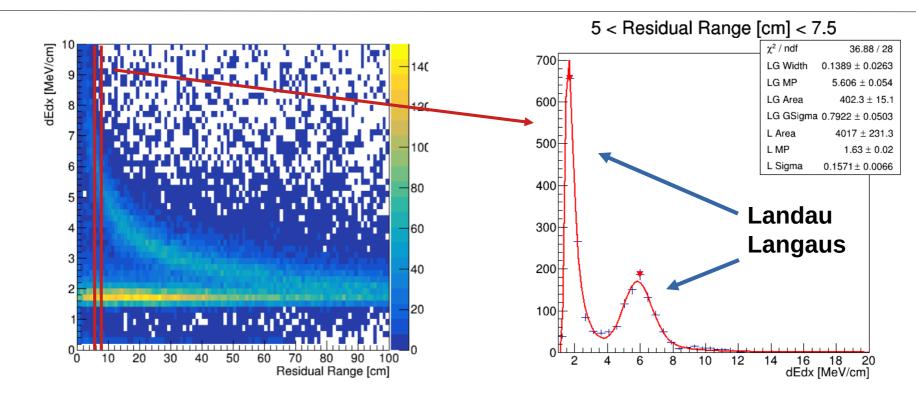




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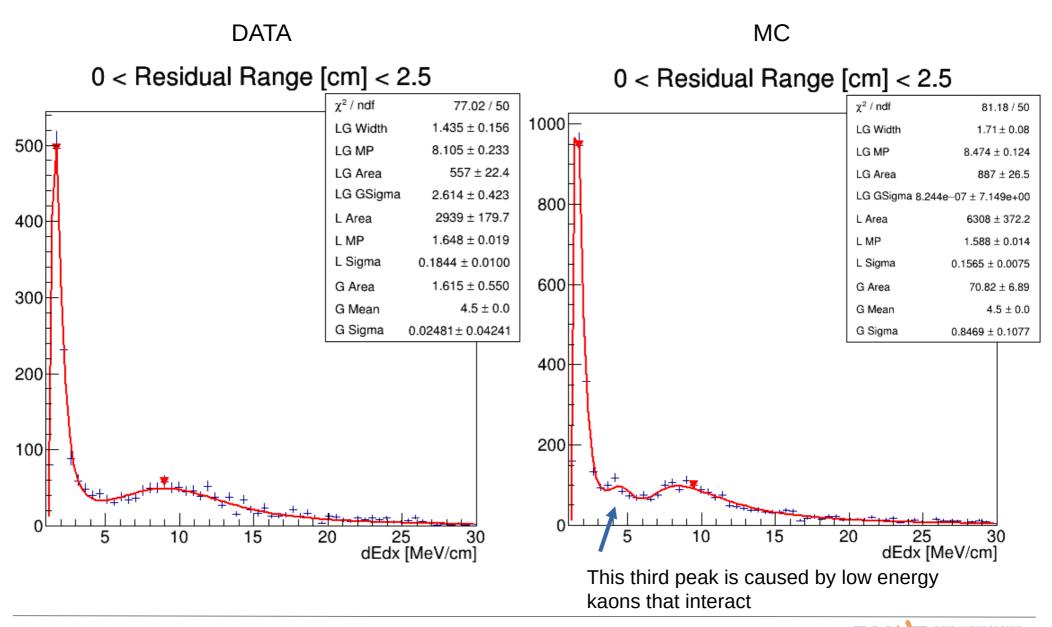




- In order to separate signal and background and present dEdx vs Residual Range measurements properly, I divided the 2D histogram in Residual range slices of 2.5 cm.
- For each slice a 1D dEdx histogram is generated, and fitted to a background+signal distribution.

Langaus = landau-gaussian convolution

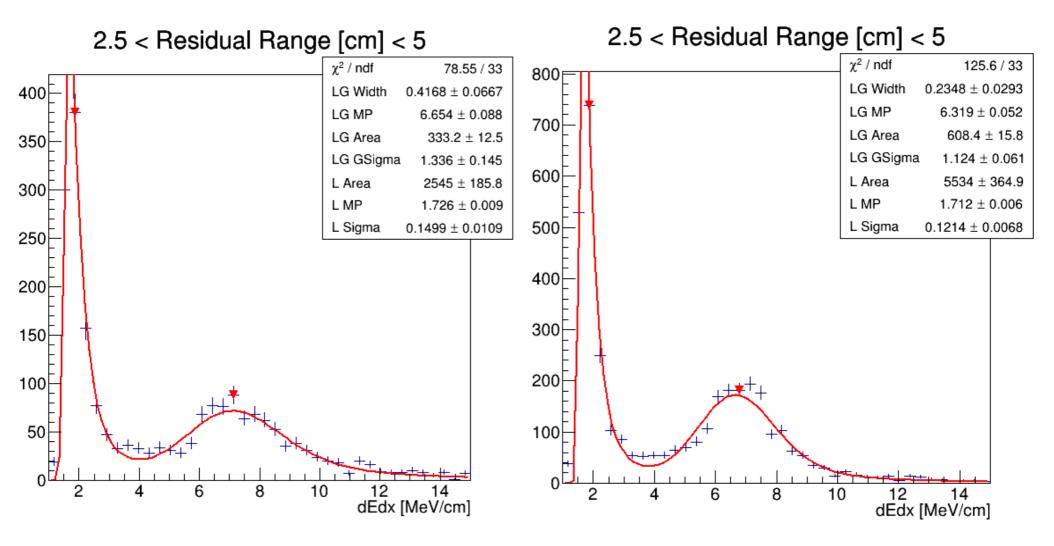




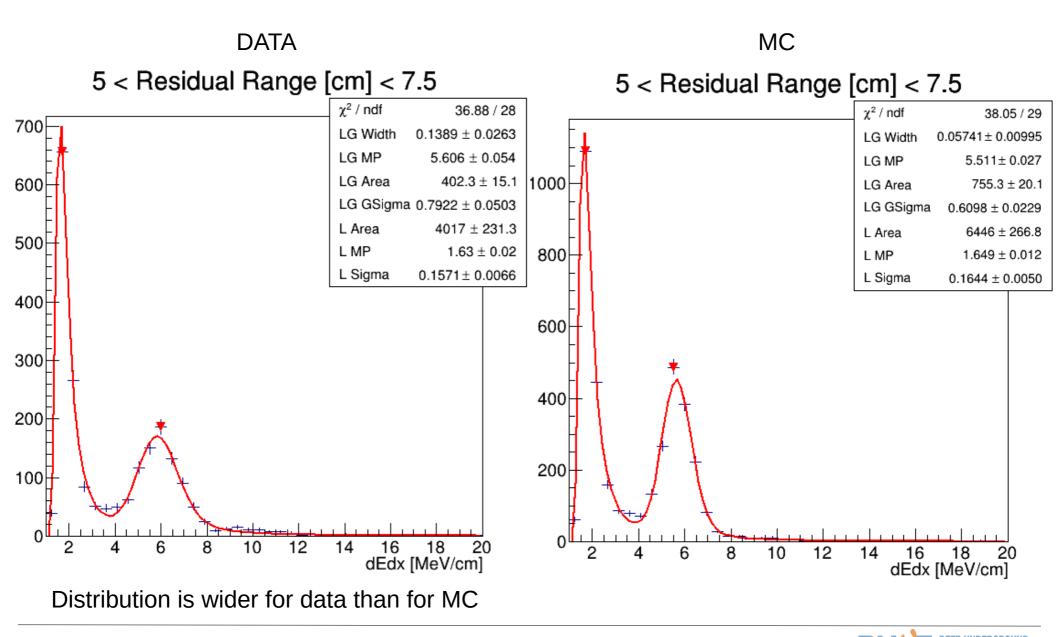
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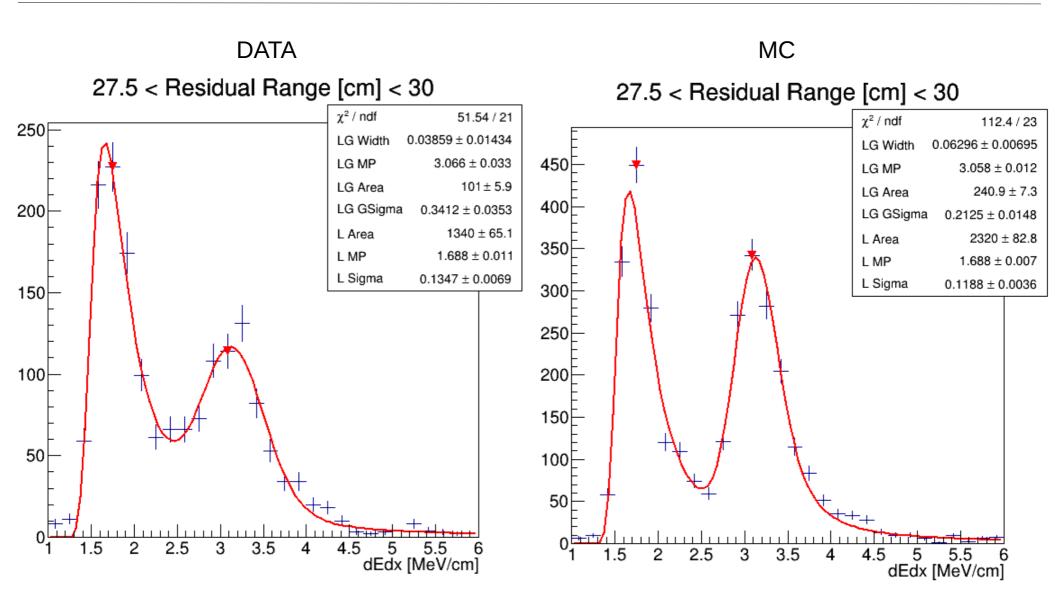
MC



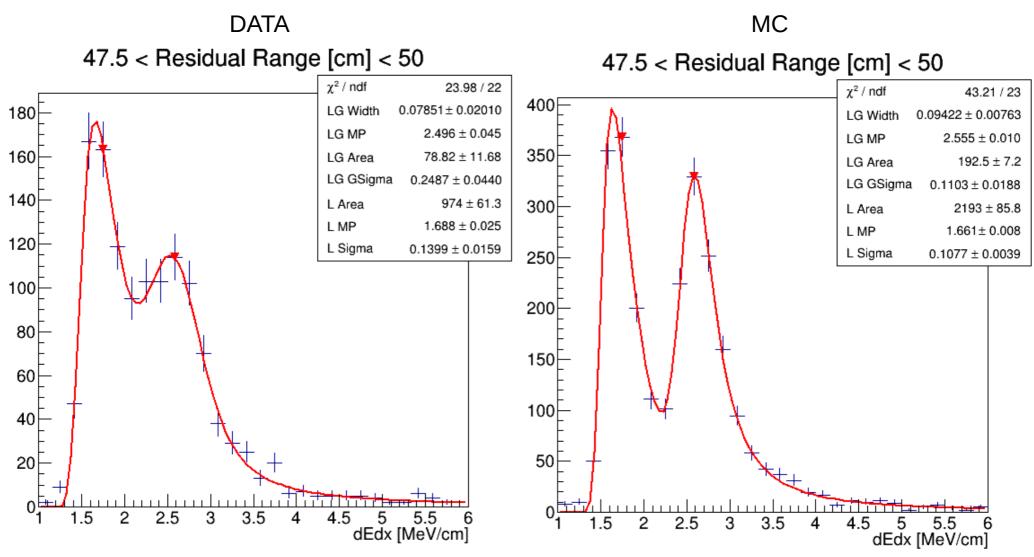






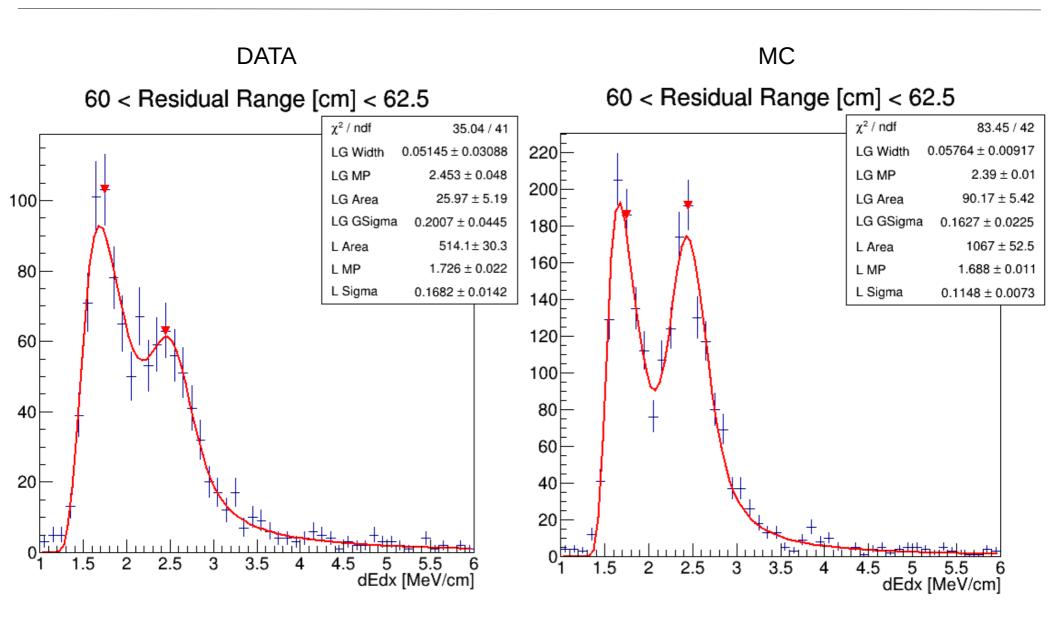






For larger residual ranges peaks are more diffused in data than in MC

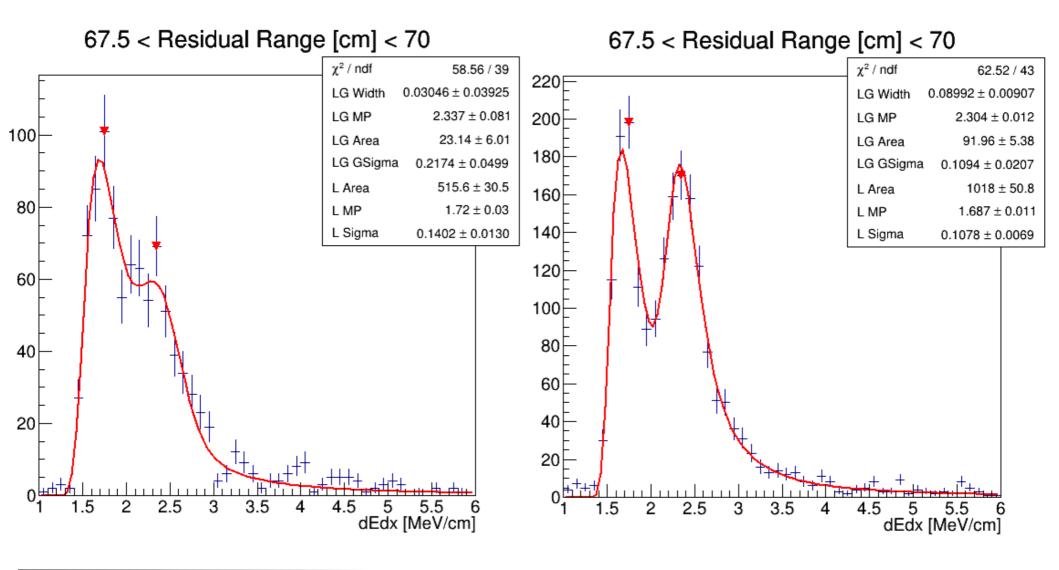






DATA

MC



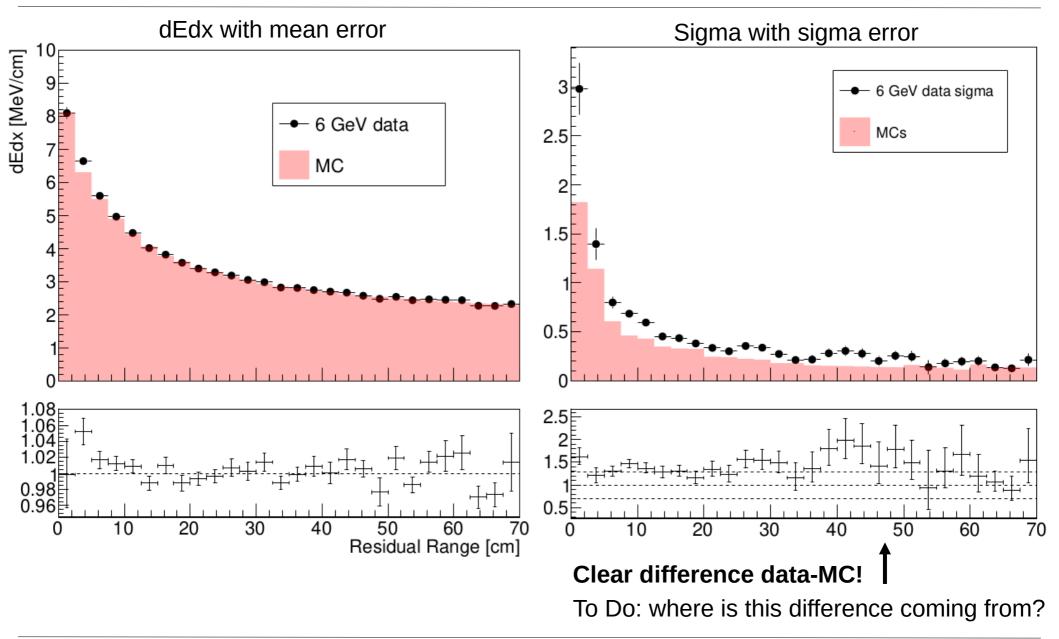


Error bars = langaus width 10 dEdx [MeV/cm] MC 9 MC bkg There is good agreement 8 6 GeV data between data and MC. 6 GeV data bkg 7 However, the error in data (width of the 6 distribution) is larger than 5 3 0 10 20 30 40 60 50 70 Residual Range [cm]



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in MC.

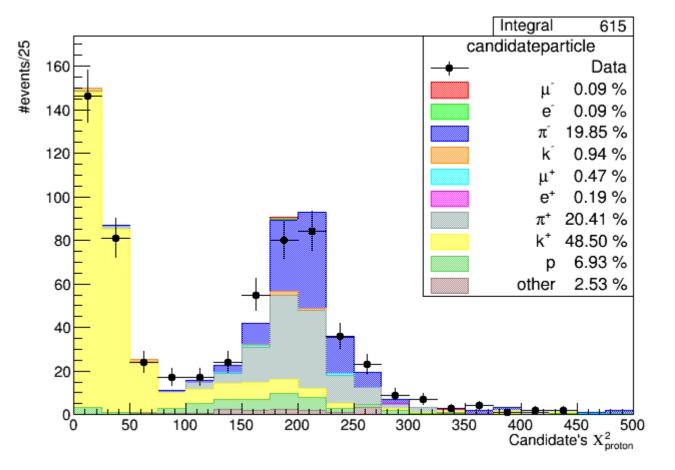






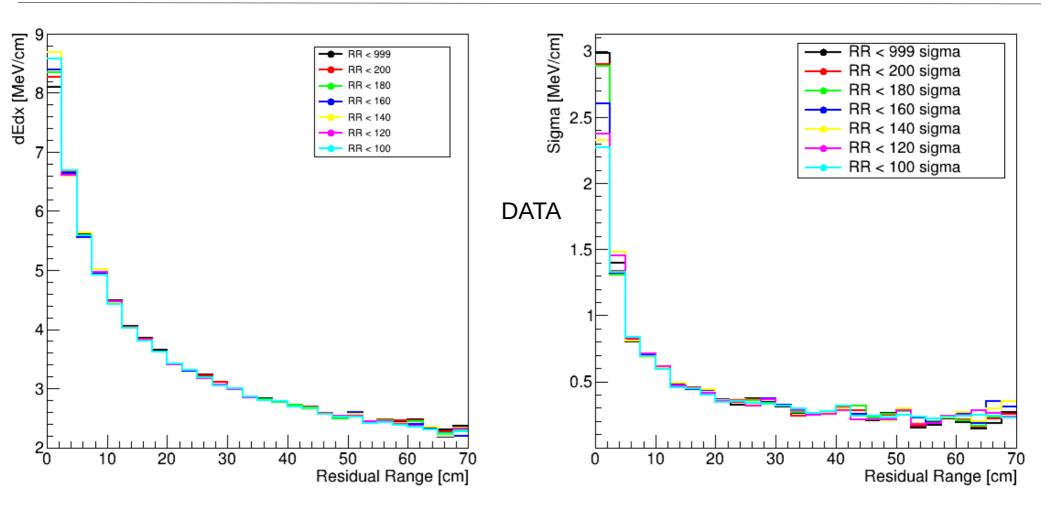
dEdx dependence on Chi2 cut

- Cutting on Chi² distribution could remove easily backgrounds.
- How much is the measurement biased by this?



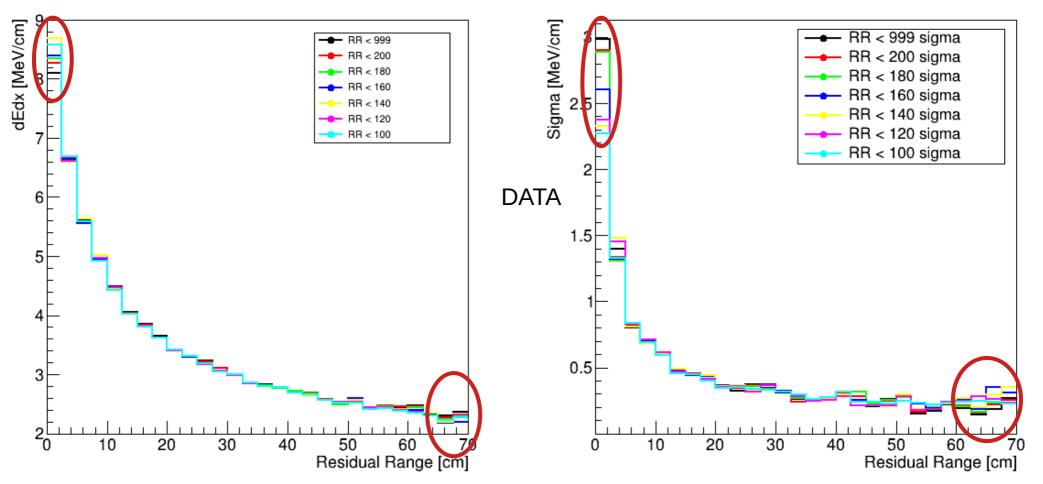


dEdx dependence on Chi2 cut





dEdx dependence on Chi2 cut

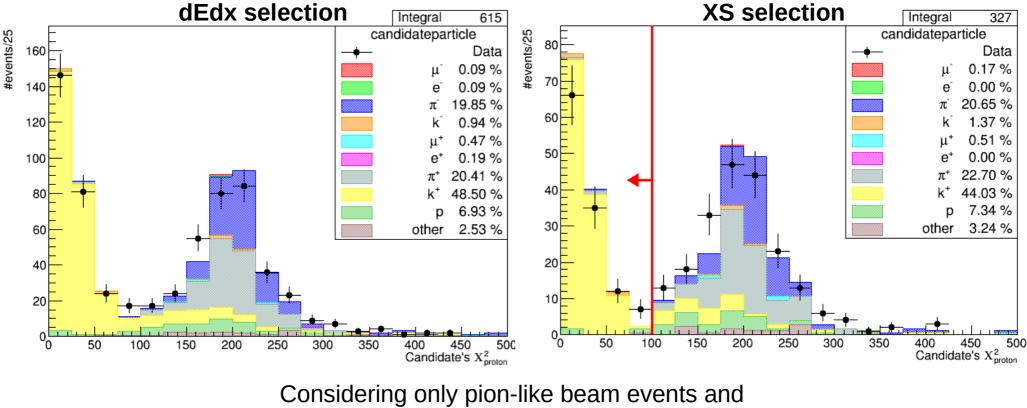


 There are only significant differences on the first and the last points, probably due to the complexity of the fit when background is present. The sigma also decreases in such points when cutting on the Chi².



Secondary Kaon production XS

For a XS measurement the dEdx information of the Kaon could be used, which will provide a high purity on the sample. Naive example:

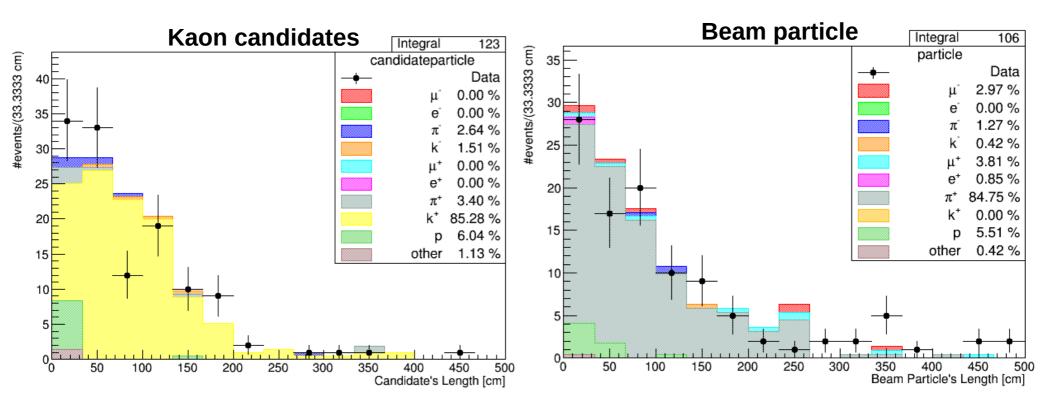


Daughters of the beam particle

Secondary Kaon production XS

Small population (\sim 100 events) with high purity of daughters (kaons, 85%) and beam particles (pions, \sim 85%).

Think about which type of measurement could be performed.





Summary

- The secondary kaon selection has been optimized and applied to all 6 GeV data.
 - Data and MC show good agreement.
 - The final selection has a purity of almost 50% and around 300 kaons, enough for a significant measurement.
 - 500 kaons are expected when 7 GeV data is also included on the analysis.
- dEdx vs ResidualRange plot can be extracted by slicing the 2D plot and fitting the background+signal distribution.
 - Data and MC show good agreement, although data seems to have a more wider distribution.
 - Cutting on the Chi² biases first and last points of the dEdx vs Residual Range plot. To be studied.
- Next steps:
 - Add 7 GeV data to the machinery.
 - Develop a selection for a secondary kaon production XS measurement.
 - Investigate the dEdx differences for data-MC and apply a systematic to the XS selection.

